Ultraviolet inverse-photoemission and photoemission spectroscopy studies of diluted magnetic semiconductors $Cd_{1-x}Mn_xTe(0 \le x \le 0.7)$

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Electronic structures of $Cd_{1-x}Mn_x$ Te films $(0 \le x \le 0.7)$ grown epitaxially on GaAs(100) substrates have been investigated by means of *in situ* measurements of conduction-band inverse-photoemission and valence-band photoemission spectra. With increasing Mn concentration, the energy position of the conduction-band minimum shifts almost linearly toward higher energy relative to the valence-band maximum (VBM) as a result of an increasing contribution of the higher-lying Mn 4s level relative to the Cd 5s level. Features observed at 3.6 and -3.4 eV relative to the VBM are ascribed to emission from the Mn $3d \downarrow$ and $3d \uparrow$ states with e_g symmetry, respectively, providing a spin-exchange splitting energy of 7.0 ± 0.2 eV. This value compares well with the predicted value in the theoretical investigation of electronic structures and magnetic properties of $Cd_{1-x}Mn_x$ Te. Apart from one-electron band theory, the whole spectrum including multielectron satellites in the energy region between -5 and -9 eV is found to be in good agreement with that calculated in terms of the configuration-interaction theory using a $Mn^{2+}(Te^{2-})_4$ model cluster.

I. INTRODUCTION

Mn-substituted II-VI diluted magnetic semiconductors (DMS's) have attracted a great deal of attention as a new class of semiconductors, since the replacement of the cations in the II-VI semiconductors yields unusual magneto-transport and magneto-optical properties.^{1,2} Such phenomena stem from the *sp*-band-Mn 3d and Mn-Mn exchange interactions through the hybridization between the *sp* band and Mn 3d states.

The band structure and magnetic properties of Mnsubstituted DMS's have been theoretically investigat ed^{3-13} based on a local-spin-density-augmentedspherical-wave method,^{3,4} a combination of *ab initio* spin-polarized band calculations, a semiempirical tightbinding model containing available experimental data, and consideration of alloying effects,⁵⁻⁸ self-consistent spin-polarized spin-density-functional band-structure calculations,⁹ spin-polarized, self-consistent local-spindensity total-energy and band-structure calculations,^{10,11} and self-consistent local-density pseudofunction theory.^{12,13} The theoretical *sp*-band-Mn 3*d* and Mn-Mn exchange constants⁵⁻⁸ are in fairly good agreement with results from the enhanced Zeeman splittings of freeexciton lines in magneto-optical experiments,¹⁴ and those from magnetization^{15,16} and neutron-scattering¹⁷ experiments, respectively.

An attempt to investigate directly the conduction-band states of $Cd_{1-x}Mn_x$ Te has been made by Franciosi and co-workers using bremsstrahlung isochromat spectroscopy (BIS) at a photon energy of 1486.6 eV with a spectrometer resolution of 0.7 eV.^{12,13} The Mn-derived feature was observed at 4.8 eV above the valence-band maximum (VBM), and a Mn 3d spin-exchange splitting

energy $(U_{\rm eff})$ was estimated to be 8.3 ± 0.4 eV. From comparison with electronic structures of antiferromagnetic zinc-blende MnTe based on a local-densityfunctional model calculation, ^{12,13} the authors claimed that the ground-state configuration of the Mn is primarily $(d\uparrow)^5(s\uparrow)(p\uparrow)$ rather than $(d\uparrow)^5s^2$. The BIS measurements, however, suffered from experimental difficulties such as electron-beam-induced sample damage and a serious electrostatic charging effect. ¹⁸ Unoccupied states of $Cd_{0.5}Mn_{0.5}Te$ have been also investigated by Kisiel *et al.* using x-ray-absorption near-edge structure (XANES) spectroscopy. ¹⁹ The Te L_1 - and L_3 -edge XANES spectra were analyzed in combination with the electronic structure calculation in terms of a localized muffin-tin orbital method with a local-spin-density approximation. The best agreement between the experiment and theory was obtained in the case for which the Mn 3*d* states were placed approximately at 3.3 ± 0.5 eV above the VBM.

In recent years, the contribution of Mn 3d states to the valence-band density of states (DOS) has been investigated experimentally to study the hybridization between the *sp*-band and Mn 3d states. $^{12,13,20-24}$ Resonant photoemission experiments using tunable synchrotron radiation (SR) successfully revealed a measure of the Mn 3d partial DOS of Cd_{1-x}Mn_xTe with a Mn concentration (x) of 0.65.²¹ The spectral features have been analyzed in terms of a configuration-interaction (CI) calculation using a Mn²⁺(Te²⁻)₄ model cluster.^{21,22} The Mn 3d photoemission spectrum has also been reproduced on the basis of the Anderson impurity model with parameters by *ab initio* calculations, including the multiplet effect.²⁵ Very recently, the electronic structures of substitutional 3d transition-metal impurities in II-VI semiconductors have been investigated by means of the CI calculation using

cluster and Anderson impurity models.²⁶ The Mn 3*d* photoemission^{21,22} and inverse-photoemission¹² spectra, $d-d^*$ optical-absorption spectra,²⁷ sp-band-Mn 3*d* exchange constants,²⁸ and donor and acceptor ionization energies²⁹ were calculated with the same set of parameters.²⁶ These theoretical investigations for Cd_{1-x}Mn_xTe (Refs. 21, 22, 25, and 26) confirm a significant Mn 3*d*-Te 5*p* hybridization which allows for sufficient screening of the 3*d* excitations by the ligand to *d*-hole charge transfer in the valence bands. In that sense, the spectral density at the top 5 eV of the valence bands can be assumed to be a good approximation for a measure of the valence-band DOS.²¹

In this paper, we present conduction- and valence-band spectra of $Cd_{1-x}Mn_x$ Te films $(0 \le x \le 0.7)$ grown epitaxially on GaAs(100) substrates, measured in situ by means of ultraviolet inverse-photoemission and photoemission spectroscopies (IPES and UPS). The IPES spectra have been successfully obtained by preparing thin epitaxial films on GaAs(100) substrates with very low resistivity to overcome the difficulty on the electrostatic charging effect. In situ measurements of IPES and UPS spectra realize a connection between these spectra at the Fermi level,³⁰ and make it possible to determine directly that the $U_{\rm eff}$ value is 7.0±0.2 eV. We shall discuss the IPES and UPS spectra in comparison with the results of the band-structure calculation in terms of the tight-binding semiempirical coherent potential approximation for $Cd_{1-x}Mn_xTe$,⁵ and also with those of the CI calculation using a $Mn^{2+}(Te^{2-})_4$ model cluster²⁶ in distinction from the one-electron band picture.

II. EXPERIMENT

The IPES spectrometer^{31,32} used in the present experiments consists of a low-energy electron gun of the Erdman-Zipf type with an energy spread of 0.25 eV, an Al reflection mirror coated with a MgF₂ film, and a bandpass photon detector with a full width at half maximum of 0.47 eV and a maximum response at 9.43 eV. All components are mounted in an ultrahigh-vacuum chamber under a base pressure below 7×10^{-11} Torr. The overall energy resolution of the spectrometer was 0.56 eV. The electron beam was injected normal to the sample surfaces.

The UPS spectrometer connected with the IPES apparatus is composed of a He discharge lamp ($\hbar\omega$ =21.2 eV) and a double-stage cylindrical-mirror analyzer to obtain angle-integrated spectra. The energy resolution was set at 0.2 eV. The working pressure of the UPS chamber was 3×10^{-9} Torr under the operation of the discharge lamp, though the base pressure was 4×10^{-10} Torr. Energy positions of the Fermi level in the IPES and UPS spectra were experimentally determined using spectra for a fresh film of polycrystalline Au.³² IPES and UPS spectra measured *in situ* on the same sample surface were connected at the Fermi level.

All measurements of IPES and UPS spectra were carried out at room temperature. The energy was referred to a VBM determined by extrapolating the steep leading edge of the highest valence-band peak to the baseline. Samples used for IPES and UPS experiments were $Cd_{1-x}Mn_x$ Te films (x = 0, 0.2, 0.3, 0.5, and 0.7) grown by the hot wall epitaxy (HWE) technique on (100)oriented Si-doped *n*-type GaAs substrates with a misorientation of 2° toward the next [110] direction,³³ and with an impurity concentration of $1.0-2.5 \times 10^{18}$ cm⁻³ or a resistivity of $1.5-2.8 \times 10^{-3} \Omega$ cm. The HWE reactor consists of a CdTe furnace with an additional Te source for compensation of the vacancies and the Mn furnace. A flip-flop method³⁴ was employed to obtain various thicknesses and x's of the films. The thickness was controlled by a repetition number of the flip-flop motion, and x by periods during the stay of the substrate over the CdTe and Mn furnaces, which were operated at 520 and 860°C, respectively.

Prior to the crystal growth, the substrates were chemically etched in a 5:1:1 solution of $H_2SO_4:H_2O_2:H_2O$. The substrate loaded into a vacuum chamber was heated at 580°C for 2 min to remove the oxide layer. During the growth, the substrate was kept constant at 300°C, and the pressure was $1-5 \times 10^{-8}$ Torr under the operation of the CdTe and Mn furnaces. After the growth of the film, the vacuum chamber was immediately evacuated into the middle of 10^{-9} Torr, keeping the substrate temperature above 250°C, and the sample was transferred into the UPS chamber. In this way, a clean surface of the $Cd_{1-x}Mn_x$ Te epitaxial film was successfully obtained. The crystal orientation and x value of the epitaxial film with a thickness of $0.5-1 \mu m$ were checked by x-ray diffraction.³⁵

The IPES spectra are much more sensitive to an electrostatic charging effect in comparison with the UPS spectra.³⁶ To avoid such an effect, the thickness of film was reduced by decreasing only the repetition number of the flip-flop motion without changing any other parameters in the growth condition for the thick $Cd_{1-x}Mn_xTe(100)$ film, until the IPES spectrum exhibited no electrostatic charging effect. The thickness of the samples used for the IPES and UPS experiments was measured using a surface profiler (high precision optical stylus surface measuring instrument, Kosaka Ltd.). The typical value of the thickness was about 30 nm.

In general, CdTe epitaxial films can grow on GaAs(100) substrates with (100) and (111) orientations, depending on the growth conditions,³⁷ and often mixed films are obtained. In the present experiments, it is reasonably assumed that thin films used for the IPES and UPS measurements would be (100)-oriented films, because $Cd_{1-x}Mn_x$ Te epitaxial films with (100) orientation grew steadily under suitable parameters mentioned above. The UPS spectra for thin $Cd_{1-x}Mn_xTe$ films, which exhibited no electrostatic charging effect in the IPES measurements, were fully consistent with those for the thick $Cd_{1-x}Mn_xTe(100)$ films. The UPS spectra for thick $Cd_{1-x}Mn_xTe(100)$ films with enough thickness for a determination of the orientation using x-ray diffraction were free from the electrostatic charging effect, and consistent with those for bulk alloys.

Residual strain is known to be important and to affect, for example, the band-gap energy of CdTe. The amount of the strain-induced change in the band-gap energy is, however, estimated to be ~ 10 meV, 38,39 and is negligible in comparison with the energy resolution of 0.56 and 0.2 eV in the IPES and UPS measurements, respectively.

The x values of the thin epitaxial films were again evaluated by x-ray photoemission spectroscopy (XPS; ESCA 5400, Perkin Elmer) using integrated emission intensities of the Cd 3d, Mn 2p, and Te 3d core levels of the epitaxial films, after IPES and UPS measurements. The XPS spectra for the bulk $Cd_{1-x}Mn_x$ Te specimens were used as a reference. The x values evaluated by XPS measurements for thin epitaxial films were in good agreement with those for thick films estimated from x-ray diffraction within $x = \pm 0.05$.

Close attention was paid to reliable ohmic contacts, which were alloyed onto the back surface of the substrate using Sn to avoid an uncontrolled voltage drop at the GaAs substrate-Mo sheet interface. The Mo sheet was used to prevent a reaction between the GaAs substrate and the CuBe sample holder during a heating process at 580 °C for 2 min.

III. RESULTS AND DISCUSSION

Figure 1 shows a series of conduction-band IPES and valence-band UPS spectra of $Cd_{1-x}Mn_x$ Te films grown epitaxially on GaAs(100) substrates with values of x of 0, 0.2, 0.3, 0.5, and 0.7. The IPES spectrum of pure CdTe exhibits peak structures at 3.7, 5.4, 6.4, and 9.0 eV above the VBM (vertical bars). From comparison with the results of a band-structure calculation based on the nonlocal semiempirical pseudopotential method of Chelikowsky and Cohen, ⁴⁰ the first peak at 3.7 eV is attributed to the DOS feature due to flat regions of conduction bands around the X_6 and X_7 symmetry points. The weak



FIG. 1. A series of the conduction-band IPES and valenceband UPS spectra of $Cd_{1-x}Mn_x$ Te films grown epitaxially on GaAs(100) substrates with x = 0, 0.2, 0.3, 0.5, and 0.7. Intensities of the IPES and UPS spectra are tentatively normalized at 12 and -1.5 eV, respectively. Vertical bars indicate the positions of structures, and arrows indicate the thresholds of the IPES spectra. Energies are referred to the VBM.

second peak at 5.4 eV, the third one at 6.4 eV, and the fourth one at 9.0 eV are ascribed to those around the Γ_7 and Γ_8 , $L_{4,5}$ and L_6 , and Λ symmetry points, respectively.

As regards the energy positions of structures, the spectrum is quantitatively consistent with the ultraviolet IPES spectrum for the CdTe(110) cleaved surface measured at normal incidence using the tunable-photon mode,⁴¹ except for the surface-resonance peak on CdTe(110) at 2.8 eV above the VBM.⁴² On the basis of the band-structure calculation of Chadi et al., 43 features observed at 3.7 and 6.4 eV above the VBM were attributed to the X_6 and Γ_8 symmetry points of the conduction bands, respectively.⁴¹ A BIS spectrum at a photon energy of 1486.6 eV on the CdTe(110) cleaved surface has been also reported, emphasizing structures at 4.1, 6.7, 9.6, 11.3, 12.5, and 15 eV above the VBM.⁴⁴ From a comparison with results of a nonlocal semiempiricalpseudopotential calculation,⁴⁰ peaks at 4.1 and 6.7 eV were ascribed to the DOS feature of conduction bands originating from states around the Δ and X symmetry points, and that derived from states in low-symmetry directions of the Brillouin zone,⁴⁴ respectively. We find that peak structures at 4.1, 6.7, and 9.6 eV in the BIS spectrum correspond to those at 3.7, 6.4, and 9.0 eV in the present IPES spectrum, respectively, after a shift of the peaks in the BIS spectrum by 0.3-0.6 eV toward lower energy.

The energy position of the conduction-band minimum (CBM) can be roughly evaluated by extrapolating the leading edge of the lowest conduction-band peak to the baseline. One notices the threshold energy of the IPES spectrum of CdTe to be 1.5 eV, in good agreement with the direct-band-gap energy of 1.53 eV. With an increase of x, the threshold shifts almost linearly toward higher energy, as shown by the vertical arrows in Fig. 1. At x = 0.7, the spectral rise at the threshold and the width of the main peak become steep and narrow, respectively, while the energy of the main peak remains almost unchanged at 3.6 eV. In addition, the main peak is assumed to exhibit a slight increase in intensity with x, if the spectra of $Cd_{1-x}Mn_xTe$ (0.2 $\leq x \leq$ 0.7) are tentatively normalized to the intensity at 12 eV (Ref. 45) in the spectrum of pure CdTe. The energy of the narrow main peak is almost independent of the incidence angle of the electron beam.

The higher-energy shift of the threshold with x is consistent with the variation of the fundamental band-gap energy determined by optical-absorption⁴⁶ and ellipsometry measurements,⁴⁷ and can be understood as a result of an increasing contribution of the higher-lying Mn 4s level relative to the Cd 5s level.^{5,46,47} The amount of the shift at x = 0.7 is, however, smaller by about 0.2 eV than that obtained from experiments on interband transitions,^{46,47} mainly due to the characteristics of the overall energy resolution of the IPES spectrometer.⁴⁸

The narrowing, constant energy position and a slight increase in intensity of the main peak with x suggest Mn-derived states with fairly localized character at 3.6 eV above the VBM. The energy position is in agreement with 3.3 ± 0.5 eV predicted for the Mn $3d\downarrow$ states from the analysis of the Te L_1 and L_3 XANES spectra.¹⁹ A constant energy of the narrow main peak for the incidence angle of the electron beam is also consistent with the localized character.

On the other hand, the UPS spectrum of pure CdTe has previously been reported by several authors and discussed in detail. We recall here that the features at -1.0, -1.5, -2.5, and -4.4 eV (vertical bars) reflect maxima in the DOS of valence bands derived mainly from flat regions around the L_3 , X_5 , $W_2 - \Sigma_1^{\min}$, and L_1 symmetry points, respectively.^{49,50} The valence-band DOS is primarily composed of Te 5p states. Increasing x from 0 to 0.3, we find no discernible change in the shape of the valence bands, except for a slight blurring of fine structures. For x above 0.5, however, additional emission shows up clearly between the two prominent peaks at -1.5 and -4.4 eV. Shapes of the UPS spectra are consistent with those for $Cd_{1-x}Mn_xTe$ ($0 \le x \le 0.65$) measured at an excitation-photon energy of 22 eV by means of SR photoemission.²⁰ An increasing spectral density between -1.5 and -4.4 eV with x is predominantly due to Mn 3d emission, with a main peak at -3.4 eV.^{20,21} Although the positions of the Cd 4d core levels have been reported to be almost independent of x in an earlier experiment,²⁰ energies of $4d_{5/2}$ and $4d_{3/2}$ relative to the VBM are found to shift almost linearly from -10.10 and -10.75 eV (x = 0) to -10.30 and -10.95 eV (x = 0.7),respectively, in the present study.⁵¹ The origin of these energy shifts is discussed below, in terms of the bandstructure calculation.⁵

While the Mn 3d features in the UPS spectra are clearly observed as an increase in intensity at -3.4 eV with x, those in the IPES spectra can be recognized only in the form of a narrowing of the main peak at a constant energy of 3.6 eV, and as a slight increase in intensity of the main peak under the tentative normalization of the spectra. We assume that the following would be main reasons why the Mn 3d features are less pronounced in the IPES spectra in comparison with those in the UPS spectra in Fig. 1: (1) The photoabsorption cross section of the Mn 3d states⁵² at 9.43 eV (IPES) is smaller by about a factor of 3 than that at 21.2 eV (UPS). (2) The Mn 3d features in the IPES spectra show up at an energy just overlapping with the first peak in the spectrum of CdTe, whereas those in the UPS spectra appear at an energy between the two prominent DOS peaks.

Figure 2(a) shows the conduction-band IPES and valence-band UPS spectra of $Cd_{0.3}Mn_{0.7}Te$ and CdTe films. The valence-band photoemission spectrum of $Cd_{0.4}Mn_{0.6}Te$ measured at an excitation-photon energy of 49.5 eV (on resonance) is also shown to demonstrate the Mn 3d emission.⁵³ One again notices a main peak at 3.6 eV and a broad and weak structure around 6.5 eV in the IPES spectrum, a valence-band structure between 0 and -2.5 eV, a main peak at -3.4 eV in the UPS spectrum, and a broad satellite between -5 and -9 eV in the spectrum measured at 49.5 eV.

First we compare Fig. 2(a) with the theoretical total and Mn 3*d* partial DOS's of $Cd_{0.4}Mn_{0.6}Te$ calculated by Ehrenreich *et al.*⁵ in Fig. 2(b). The total DOS of CdTe is also shown in Fig. 2(c) for the convenience of discussion.



FIG. 2. (a) Conduction-band IPES and valence-band UPS spectra of $Cd_{0.3}Mn_{0.7}$ Te and CdTe films. To demonstrate the Mn 3*d* emission, the valence-band spectrum of $Cd_{0.4}Mn_{0.6}$ Te measured at 49.5 eV (on resonance) is also shown. (b) Total and Mn 3*d* partial (shaded area) DOS's of $Cd_{0.4}Mn_{0.6}$ Te and (c) total DOS of CdTe based on tight-binding calculations (Ref. 5).

The zero energy in the theoretical DOS's is referred to the VBM of CdTe. In Fig. 2(b), a prominent DOS peak due to the unoccupied Mn $3d\downarrow$ states with e_g symmetry is placed at 3.6 eV. The energy position of this peak is coincident with that of the first DOS peak of CdTe. On the other hand, the occupied Mn $3d\uparrow$ states split into two peaks as a result of sp-d hybridization. The lower states with t_{2g} symmetry hybridize more strongly than the higher states with e_g symmetry in the tetrahedral environment, and shift to lower energy due to a repulsion from the upper Te 5p valence bands. The corresponding 3d admixture in the upper valence-band region is responsible for the Mn 3d DOS in the energy region between 0 and -2 eV and the slight shift of the VBM toward higher energy. Such a shift of the VBM is, in fact, observed in a form of an increase in energy separations between the VBM and Cd 4d core levels in Fig. 1.

The $U_{\rm eff}$ value, the energy necessary to add one 3d electron to a ${\rm Mn}^{2+}$ ion, ${}^{5-8}$ is taken to be 7.0 eV. The connections between the electronic structure in Fig. 2(b) and the *sp*-band-Mn 3d and Mn-Mn exchange interactions have been extensively investigated.^{6,7} In particular, the Mn-Mn exchange constant has been calculated quantitatively and shown to result primarily from hybridization-induced antiferromagnetic superexchange. Then authors developed a physically transparent model of both the *sp*-band-Mn 3d and Mn-Mn exchange using only four parameters: the valence-band-edge energy E_v , the energy of occupied Mn 3d states E_d , the *p*-*d* hybridi-

zation parameter V_{pd} , and U_{eff} . For numerical results, the principal uncertainty lies mainly in the parameters of V_{pd} , and U_{eff} .⁶

One notices that the Mn-derived features in the IPES and UPS spectra in Fig. 2(a) are in good agreement with those in the calculated DOS curves. Taking into account the experimental features observed for the narrow main peak at 3.6 eV in the IPES spectrum as well as the comparison between the experiment and theory in Fig. 2, we assign the peak at 3.6 eV to the Mn $3d\downarrow$ states, and evaluate the $U_{\rm eff}$ value to be 7.0±0.2 eV from Fig. 2(a). The splitting energy of $7.0\pm0.2~\text{eV}$ is in quantitative agreement with the predicted $U_{\rm eff}$ value, and supports the electronic structure model for the estimation of the nearest-neighbor Mn-Mn exchange constant (J^{dd}) of $Cd_{1-x}Mn_xTe$, using input parameters such as $E_v - E_d = 3.4$ eV taken from photoemission experi-ments, $^{20,21} U_{\text{eff}} = 7.0$ eV, $V_{pd} = 0.219$ eV estimated from the experimental *sp-d* exchange constant, 54 and the Mn-Te bond length of 2.759 Å determined by extended x-ray-absorption fine-structure experiments.⁵⁵ Authors fur-ther calculated a chemical trend of J^{dd} in Cd_{1-x}Mn_xY (Y = Te,Se,S). The predicted increase in J^{dd} from telluride to selenide is in reasonable agreement with the increase observed experimentally. The larger predicted increase in J^{dd} from selenide to sulfide overestimates the experimental trend, which may be corrected when more accurate input parameters become available.

Recent first-principles calculations for $Cd_{1-x}Mn_xTe$ by Wei and Zunger predicted a U_{eff} of 4.9 eV.^{10,11} Calculations for paramagnetic zinc-blende MnTe by Masek, Velicky, and Janis provided a value of 5.5 eV, ⁵⁶ and those for antiferromagnetic zinc-blende MnTe by Podgórny suggested a value of about 4 eV for the splitting energy. All calculated values are substantially smaller than our experimental value of 7.0 ± 0.2 eV.⁵⁷ On the other hand, the earlier experimental value determined from the BIS measurements is 8.3 ± 0.4 eV,¹² and substantially larger than the present value. For this discrepancy, it should be noted that the photoemission and BIS measurements were made for different cleaved surfaces of Cd_{0.8}Mn_{0.2}Te alloy, ¹² though the position of the Fermi level in the band gap depends significantly on the cleaved faces of crystals. In situ measurements of the IPES and UPS spectra in the present study rule out such an irreversible shift of the Fermi level.

With respect to the Mn-derived feature at 4.6 eV in the reflectivity⁵⁸ and ellipsometry⁴⁷ measurements of $Cd_{1-x}Mn_x$ Te, Kendelewicz tentatively interpreted the structure as coming from interband transitions from the *sp* valence band to the unoccupied Mn 3*d* states.⁵⁸ The initial states were related to the maximum in the valence-band DOS at 1.8 eV below the VBM: the states around the X_5 symmetry point. This places the unoccupied Mn 3*d* states at 2.8 eV above the VBM. On the other hand, Franciosi *et al.* attributed the structure to optical transition from the top of the *sp* valence-band states to the unoccupied Mn 3*d* states at 4.8 ±0.3 eV above the VBM on the basis of their experimental result.¹² Both values of 2.8 and 4.8 eV are in rather poor agreement

with the present result of 3.6 eV.

The location of the unoccupied Mn 3d states at 3.6 eV above the VBM in the present study provides a plausible interpretation. We remember that the valence-band spectrum of pure CdTe exhibits a DOS structure at -1.0 eV, which is primarily derived from the flat region of valence bands around the L_3 symmetry point. In addition, the shape of the *sp* part of the valence-band spectrum does not change appreciably when Mn is added.²⁰ The location of the unoccupied Mn 3d states at 3.6 eV above the VBM in the present study thus suggests that the optical transition at 4.6 eV is most probably due to transitions from the states around the L_3 symmetry point at -1.0eV to the unoccupied Mn 3d states, in agreement with the assignment by Larson *et al.*⁶

In spite of the good correspondence between the experiment and energy-band theory, the theory cannot interpret the multielectron satellite in the energy region between -5 and -9 eV. Nor can it explain the intraatomic d-d* optical absorption observed at about 2.2 eV for Cd_{1-x}Mn_xTe with $x \ge 0.4$.²⁷ Gunnarsson, Postni-



FIG. 3. (a) Conduction-band IPES spectrum of $Cd_{0.3}Mn_{0.7}Te$ film, valence-band photoemission spectrum of Cd_{0.4}Mn_{0.6}Te measured at 49.5 eV (on resonance), and a measure of the Mn 3d partial DOS evaluated from resonant photoemission experiment in the Mn 3p-3d core excitation region (dotted curves). (b) Mn 3*d*-derived photoemission spectra of $Cd_{1-x}Mn_xTe$ calculated on the basis of the configuration-interaction theory (Ref. 26). In the calculation, d^5 , $d^6\underline{L}$, $d^7\underline{L}^2$ and d^4 , $d^5\underline{L}$, $d^6\underline{L}^2$ configurations are taken into account for the initial and final states, respectively, where L represents a ligand hole. The line spectra are calculated using parameters of U=4.0 eV, $\Delta=2.0$ eV, and $(pd\sigma) = -1.1$ eV. Here U is Coulomb correlation energy of the Mn 3d electrons, and Δ is the ligand-to-metal charge-transfer energy. In addition, $(pd\sigma)$ represents a p-d transfer integral and $(pd\sigma)/(pd\pi)$ is fixed at -2.16. The solid curves are constructed by a convolution of the line spectra, with Gaussian and Lorentzian functions for the sake of comparison.

kov, and Anderson presented the results of *ab initio* calculations for parameters in the Anderson model, such as the energy-dependent *p-d* hybridization parameters and a Mn 3*d* Coulomb correlation energy of 7.3 eV.²⁵ Without any empirical parameters, the Mn 3*d* photoemission spectrum was fairly well reproduced including the multielectron satellites.

Very recently, Mizokawa and Fujimori calculated the Mn 3d-derived inverse-photoemission and photoemission spectra of $Cd_{1-x}Mn_x$ Te in terms of the CI theory.²⁶ Figure 3 exhibits (a) the conduction-band IPES spectrum of Cd_{0.3}Mn_{0.7}Te film, valence-band photoemission spectrum of Cd_{0.4}Mn_{0.6}Te measured at 49.5 eV (on resonance), and a measure of the Mn 3d partial DOS evaluated from resonant photoemission experiments in the Mn 3p-3d core excitation region⁵³ (dotted curves), and (b) the calculated spectra (solid curves).²⁶ CI analysis revealed that the feature between 0 and -5 eV with a main peak at -3.4eV is predominantly due to transitions into the $d^{5}L$ final states, whereas the satellite between -5 and -9 eV is ascribed to transitions into the d^4 final states. Here the <u>L</u> denotes a ligand hole. On the same line of argument, the main peak at 3.6 eV in the Mn 3d inverse-photoemission spectrum is attributed to transitions into the d^6 final states.

Previous analysis for the Mn 3d partial DOS of $Cd_{1-x}Mn_x$ Te provided a Mn 3d Coulomb correlation energy of 7.5 eV (Refs. 21 and 22) $[U \equiv E(3d^4) + E(3d^6) - 2E(3d^5)]$, where $E(3d^n)$ is the center of gravity of the 3dⁿ multiplet], different from the value of 4.0 eV in Ref. 26. The discrepancy in U originates mainly from the fact that the relevant optical and magnetic properties and impurity states have been interpreted consistently using the same set of parameters.⁵⁹ In addition, the previous analysis was performed using only the d⁵, d^6L and d^4 , d^5L configurations as the initial and final states, respectively, while recent analysis takes further account of the d^7L^2 and d^6L^2 configurations for the initial and final states. The inclusion of the d^7L^2 and d^6L^2 configurations has an influence upon the number and energy positions of the structures in the spectra.

IV. CONCLUSIONS

We have measured the conduction-band IPES and valence-band UPS spectra of $Cd_{1-x}Mn_x$ Te films $(0 \le x \le 0.7)$ grown epitaxially on GaAs(100) substrates. The IPES spectrum of pure CdTe shows peak structures at 3.7, 5.4, 6.4, and 9.0 eV above the VBM. On the basis of the results of band-structure calculation,⁴⁰ these structures are interpreted to be associated with the DOS features due to particular flat regions of conduction bands around the X_6 and X_7 , Γ_7 and Γ_8 , $L_{4,5}$ and L_6 , and A symmetry points, respectively. With increasing x, the energy position of the CBM relative to the VBM shifts linearly toward higher energy as a result of an increasing

contribution of the Mn 4s states to the conduction bands.

The energy position of the Mn $3d \downarrow$ states at 3.6 eV above the VBM in the present study is in good agreement with that predicted from the analysis of the Te L_1 and L_3 edge XANES spectra combined with the electronic structure calculation.¹⁹ The U_{eff} value is directly estimated to be 7.0±0.2 eV. This value compares well with the predicted spin-exchange splitting energy of 7.0 eV in support of the electronic structure model, ⁵⁻⁸ though the present result is substantially smaller than the earlier experimental value of 8.3 ± 0.4 eV from the photoemission and BIS measurements.¹²

For the initial states of transitions responsible for the Mn-derived feature at 4.6 eV in the reflectivity spectra, ⁵⁸ the valence-band states around the X_5 symmetry points are assumed to be the most probable candidates based on the location of the Mn $3d \downarrow$ states at 3.6 eV.

Aside from the energy-band theory, the peak at 3.6 eV, features between 0 and -5 eV with a main peak at -3.4 eV, and those between -5 and -9 eV are assigned to the d^{6} , $d^{5}L$, and d^{4} final states, respectively, on the basis of CI calculations using cluster²⁶ and Anderson impurity^{25,26} models.

In situ measurements of IPES and UPS spectra of $Zn_{1-x}Mn_xTe$ films $(0 \le x \le 0.7)$ grown epitaxially on GaAs(100) substrates by the HWE technique have recently been made.⁶⁰ The IPES spectrum of pure ZnTe exhibits peak structures at 4.0 and 6.8 eV above the VBM, reflecting DOS maxima of the sp conduction bands. With the increase of x, a Mn-derived feature shows up clearly at 3.5 eV, namely 0.5 eV below the first peak in the spectrum of ZnTe. Peaks at 3.5 and -3.7 eV (Ref. 23) in the IPES and UPS spectra have been ascribed to emission from the Mn $3d \downarrow$ and $3d \uparrow$ states with e_g symmetry, respectively. In spite of the difference in band structure between ZnTe and CdTe, the $U_{\rm eff}$ of 7.2 \pm 0.2 eV evaluated for $Zn_{1-x}Mn_xTe$ is very close to 7.0±0.2 eV in the present study for $Cd_{1-x}Mn_xTe$, implying the intraatomic nature of the U_{eff} .

ACKNOWLEDGMENTS

The authors are grateful to Professor T. Oguchi for stimulating discussions on theoretical aspects, to Professor S. Miyazaki and Dr. M. Ohashi for measurements of thickness and XPS spectra of epitaxial films, and to A. Minami for an electron-probe microanalysis of bulk specimens, respectively. We thank also the staff of SRL-ISSP for the operation of SOR-RING and technical support. This work is partly supported by the Grant-in-Aid for Scientific Research from the Ministry of Education, Science and Culture, Japan, Iketani Science and Technology Foundation, The Ogasawara Foundation for The Promotion of Science and Technology, The Murata Science Foundation, and Shimazu Science Foundation.

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